

<b>Notice of References Cited</b>	Application/Control No. 09/783,255	Applicant(s)/Patent Under Reexamination OZAWA, TOSHIRO	
	Examiner S. Lao	Art Unit 2126	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,195,694	02-2001	Chen et al.	709/220
	B	US-6,453,259	09-2002	Infiesto, Douglas C.	702/122
	C	US-6,754,904	06-2004	Cooper et al.	725/32
	D	US-5,956,483	09-1999	Grate et al.	709/203
	E	US-5,682,534	10-1997	Kapoor et al.	719/328
	F	US-6,718,399	04-2004	Chernick et al.	719/330
	G	US-6,119,166	09-2000	Bergman et al.	709/232
	H	US-6,675,385	01-2004	Wang, Jeffrey Yutong	725/39
	I	US-5,532,753	07-1996	Buchner et al.	725/56
	J	US-5,491,800	02-1996	Goldsmith et al.	709/221
	K	US-5,218,699	06-1993	Brandle et al.	719/328
	L	US-6,112,246	08-2000	Horbal et al.	709/230
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.